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Understanding Embedded - FPGAs (Field Programmable Gate Array)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

Details	
Product Status	Obsolete
Number of LABs/CLBs	576
Number of Logic Elements/Cells	1368
Total RAM Bits	18432
Number of I/O	192
Number of Gates	30000
Voltage - Supply	4.75V ~ 5.25V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 85°C (TJ)
Package / Case	256-BBGA
Supplier Device Package	256-PBGA (27x27)
Purchase URL	https://www.e-xfl.com/product-detail/xilinx/xcs30-3bg256c

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong



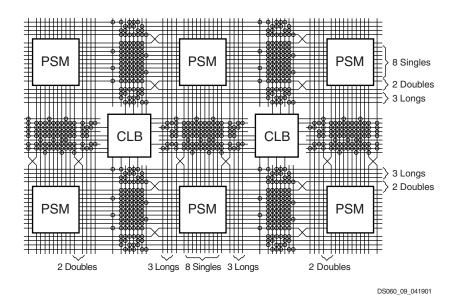


Figure 8: Spartan/XL CLB Routing Channels and Interface Block Diagram

CLB Interface

A block diagram of the CLB interface signals is shown in Figure 9. The input signals to the CLB are distributed evenly on all four sides providing maximum routing flexibility. In general, the entire architecture is symmetrical and regular. It is well suited to established placement and routing algorithms. Inputs, outputs, and function generators can freely swap positions within a CLB to avoid routing congestion during the placement and routing operation. The exceptions are the clock (K) input and CIN/COUT signals. The K input is routed to dedicated global vertical lines as well as four single-length lines and is on the left side of the CLB. The CIN/COUT signals are routed through dedicated interconnects which do not interfere with the general routing structure. The output signals from the CLB are available to drive both vertical and horizontal channels.

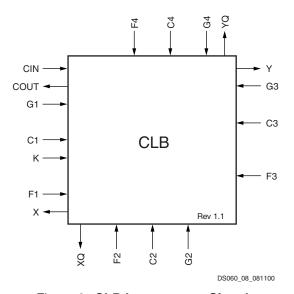


Figure 9: CLB Interconnect Signals

Programmable Switch Matrices

The horizontal and vertical single- and double-length lines intersect at a box called a programmable switch matrix (PSM). Each PSM consists of programmable pass transistors used to establish connections between the lines (see Figure 10).

For example, a single-length signal entering on the right side of the switch matrix can be routed to a single-length line on the top, left, or bottom sides, or any combination thereof, if multiple branches are required. Similarly, a double-length signal can be routed to a double-length line on any or all of the other three edges of the programmable switch matrix.

Single-Length Lines

Single-length lines provide the greatest interconnect flexibility and offer fast routing between adjacent blocks. There are eight vertical and eight horizontal single-length lines associated with each CLB. These lines connect the switching matrices that are located in every row and column of CLBs. Single-length lines are connected by way of the programmable switch matrices, as shown in Figure 10. Routing connectivity is shown in Figure 8.

Single-length lines incur a delay whenever they go through a PSM. Therefore, they are not suitable for routing signals for long distances. They are normally used to conduct signals within a localized area and to provide the branching for nets with fanout greater than one.



- The 16 x 1 single-port configuration contains a RAM array with 16 locations, each one-bit wide. One 4-bit address decoder determines the RAM location for write and read operations. There is one input for writing data and one output for reading data, all at the selected address.
- The (16 x 1) x 2 single-port configuration combines two 16 x 1 single-port configurations (each according to the preceding description). There is one data input, one data output and one address decoder for each array. These arrays can be addressed independently.
- The 32 x 1 single-port configuration contains a RAM array with 32 locations, each one-bit wide. There is one data input, one data output, and one 5-bit address decoder.
- The dual-port mode 16 x 1 configuration contains a RAM array with 16 locations, each one-bit wide. There are two 4-bit address decoders, one for each port. One port consists of an input for writing and an output for reading, all at a selected address. The other port consists of one output for reading from an independently selected address.

The appropriate choice of RAM configuration mode for a given design should be based on timing and resource requirements, desired functionality, and the simplicity of the design process. Selection criteria include the following: Whereas the 32 x 1 single-port, the (16 x 1) x 2 single-port, and the 16 x 1 dual-port configurations each use one entire CLB, the 16 x 1 single-port configuration uses only one half of a CLB. Due to its simultaneous read/write capability, the dual-port RAM can transfer twice as much data as the single-port RAM, which permits only one data operation at any given time.

CLB memory configuration options are selected by using the appropriate library symbol in the design entry.

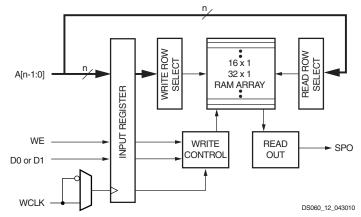
Single-Port Mode

There are three CLB memory configurations for the single-port RAM: 16×1 , $(16 \times 1) \times 2$, and 32×1 , the functional organization of which is shown in Figure 12.

The single-port RAM signals and the CLB signals (Figure 2, page 4) from which they are originally derived are shown in Table 9.

Table 9: Single-Port RAM Signals

RAM Signal	Function	CLB Signal
D0 or D1	Data In	DIN or H1
A[3:0]	Address	F[4:1] or G[4:1]
A4 (32 x 1 only)	Address	H1
WE	Write Enable	SR
WCLK	Clock	К
SPO	Single Port Out (Data Out)	F _{OUT} or G _{OUT}



Notes:

- The (16 x 1) x 2 configuration combines two 16 x 1 single-port RAMs, each with its own independent address bus and data input. The same WE and WCLK signals are connected to both RAMs.
- 2. n = 4 for the 16 x 1 and (16 x 1) x 2 configurations. n = 5 for the 32 x 1 configuration.

Figure 12: Logic Diagram for the Single-Port RAM

Writing data to the single-port RAM is essentially the same as writing to a data register. It is an edge-triggered (synchronous) operation performed by applying an address to the A inputs and data to the D input during the active edge of WCLK while WE is High.

The timing relationships are shown in Figure 13. The High logic level on WE enables the input data register for writing. The active edge of WCLK latches the address, input data, and WE signals. Then, an internal write pulse is generated that loads the data into the memory cell.



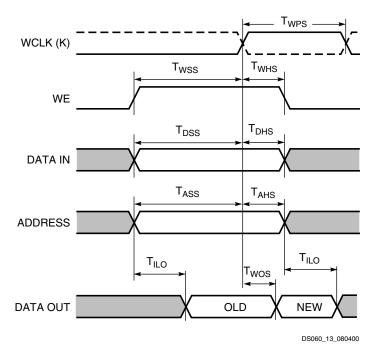


Figure 13: Data Write and Access Timing for RAM

WCLK can be configured as active on either the rising edge (default) or the falling edge. While the WCLK input to the RAM accepts the same signal as the clock input to the associated CLB's flip-flops, the sense of this WCLK input can be

inverted with respect to the sense of the flip-flop clock inputs. Consequently, within the same CLB, data at the RAM SPO line can be stored in a flip-flop with either the same or the inverse clock polarity used to write data to the RAM.

The WE input is active High and cannot be inverted within the CLB.

Allowing for settling time, the data on the SPO output reflects the contents of the RAM location currently addressed. When the address changes, following the asynchronous delay T_{ILO} , the data stored at the new address location will appear on SPO. If the data at a particular RAM address is overwritten, after the delay T_{WOS} , the new data will appear on SPO.

Dual-Port Mode

In dual-port mode, the function generators (F-LUT and G-LUT) are used to create a 16 x 1 dual-port memory. Of the two data ports available, one permits read and write operations at the address specified by A[3:0] while the second provides only for read operations at the address specified independently by DPRA[3:0]. As a result, simultaneous read/write operations at different addresses (or even at the same address) are supported.

The functional organization of the 16 \times 1 dual-port RAM is shown in Figure 14. The dual-port RAM signals and the

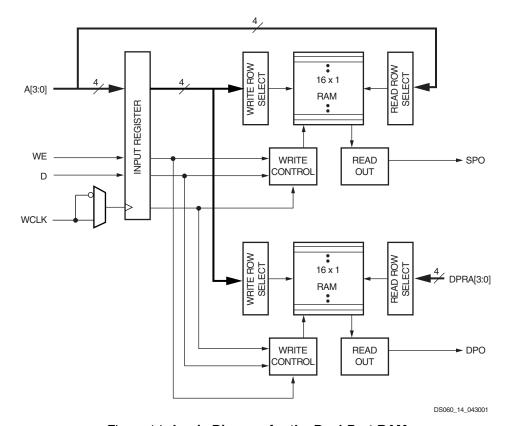


Figure 14: Logic Diagram for the Dual-Port RAM



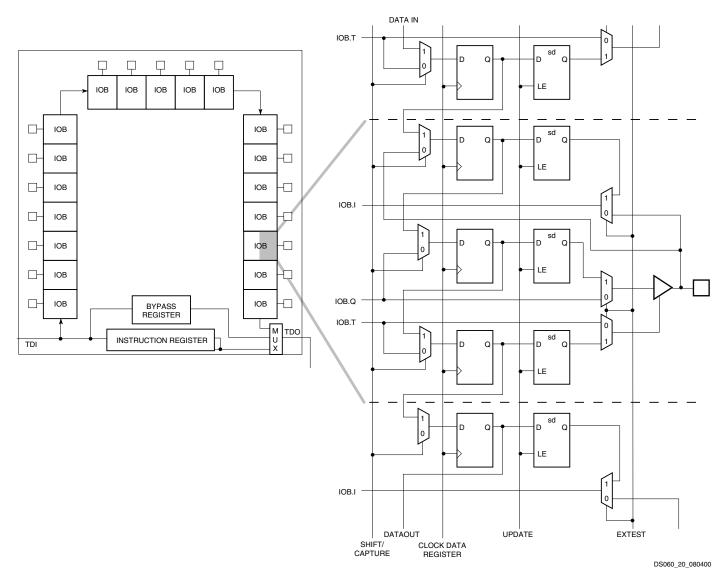


Figure 20: Spartan/XL Boundary Scan Logic



Even if the boundary scan symbol is used in a design, the input pins TMS, TCK, and TDI can still be used as inputs to be routed to internal logic. Care must be taken not to force the chip into an undesired boundary scan state by inadvertently applying boundary scan input patterns to these pins. The simplest way to prevent this is to keep TMS High, and then apply whatever signal is desired to TDI and TCK.

Avoiding Inadvertent Boundary Scan

If TMS or TCK is used as user I/O, care must be taken to ensure that at least one of these pins is held constant during configuration. In some applications, a situation may occur where TMS or TCK is driven during configuration. This may cause the device to go into boundary scan mode and disrupt the configuration process.

To prevent activation of boundary scan during configuration, do either of the following:

- TMS: Tie High to put the Test Access Port controller in a benign RESET state.
- TCK: Tie High or Low—do not toggle this clock input.

For more information regarding boundary scan, refer to the Xilinx Application Note, "Boundary Scan in FPGA Devices."

Boundary Scan Enhancements (Spartan-XL Family Only)

Spartan-XL devices have improved boundary scan functionality and performance in the following areas:

IDCODE: The IDCODE register is supported. By using the IDCODE, the device connected to the JTAG port can be determined. The use of the IDCODE enables selective configuration dependent on the FPGA found.

The IDCODE register has the following binary format:

vvvv:ffff:fffa:aaaa:aaaa:cccc:cccc1

where

c = the company code (49h for Xilinx)

a = the array dimension in CLBs (ranges from 0Ah for XCS05XL to 1Ch for XCS40XL)

f = the family code (02h for Spartan-XL family)

v = the die version number

Table 13: IDCODEs Assigned to Spartan-XL FPGAs

FPGA	IDCODE
XCS05XL	0040A093h
XCS10XL	0040E093h
XCS20XL	00414093h
XCS30XL	00418093h
XCS40XL	0041C093h

Configuration State: The configuration state is available to JTAG controllers.

Configuration Disable: The JTAG port can be prevented from configuring the FPGA.

TCK Startup: TCK can now be used to clock the start-up block in addition to other user clocks.

CCLK Holdoff: Changed the requirement for Boundary Scan Configure or EXTEST to be issued prior to the release of INIT pin and CCLK cycling.

Reissue Configure: The Boundary Scan Configure can be reissued to recover from an unfinished attempt to configure the device.

Bypass FF: Bypass FF and IOB is modified to provide DRCLOCK only during BYPASS for the bypass flip-flop, and during EXTEST or SAMPLE/PRELOAD for the IOB register.

Power-Down (Spartan-XL Family Only)

All Spartan/XL devices use a combination of efficient segmented routing and advanced process technology to provide low power consumption under all conditions. The 3.3V Spartan-XL family adds a dedicated active Low power-down pin (PWRDWN) to reduce supply current to 100 μA typical. The PWRDWN pin takes advantage of one of the unused No Connect locations on the 5V Spartan device. The user must de-select the "5V Tolerant I/Os" option in the Configuration Options to achieve the specified Power Down current. The PWRDWN pin has a default internal pull-up resistor, allowing it to be left unconnected if unused.

 V_{CC} must continue to be supplied during Power-down, and configuration data is maintained. When the \overline{PWRDWN} pin is pulled Low, the input and output buffers are disabled. The inputs are internally forced to a logic Low level, including the MODE pins, DONE, CCLK, and \overline{TDO} , and all internal pull-up resistors are turned off. The $\overline{PROGRAM}$ pin is not affected by Power Down. The GSR net is asserted during Power Down, initializing all the flip-flops to their start-up state.

PWRDWN has a minimum pulse width of 50 ns (Figure 23). On entering the Power-down state, the inputs will be disabled and the flip-flops set/reset, and then the outputs are disabled about 10 ns later. The user may prefer to assert the GTS or GSR signals before PWRDWN to affect the order of events. When the PWRDWN signal is returned High, the inputs will be enabled first, followed immediately by the release of the GSR signal initializing the flip-flops. About 10 ns later, the outputs will be enabled. Allow 50 ns after the release of PWRDWN before using the device.



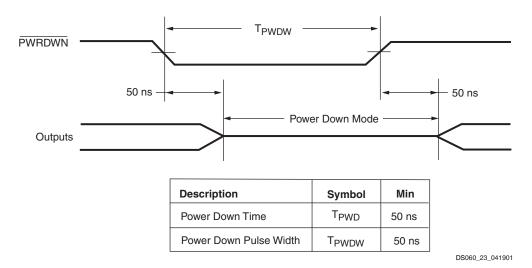


Figure 23: PWRDWN Pulse Timing

Power-down retains the configuration, but loses all data stored in the device flip-flops. All inputs are interpreted as Low, but the internal combinatorial logic is fully functional. Make sure that the combination of all inputs Low and all flip-flops set or reset in your design will not generate internal oscillations, or create permanent bus contention by activating internal bus drivers with conflicting data onto the same long line.

During configuration, the PWRDWN pin must be High. If the Power Down state is entered before or during configuration, the device will restart configuration once the PWRDWN signal is removed. Note that the configuration pins are affected by Power Down and may not reflect their normal function. If there is an external pull-up resistor on the DONE pin, it will be High during Power Down even if the device is not yet configured. Similarly, if PWRDWN is asserted before configuration is completed, the INIT pin will not indicate status information.

Note that the PWRDWN pin is not part of the Boundary Scan chain. Therefore, the Spartan-XL family has a separate set of BSDL files than the 5V Spartan family. Boundary scan logic is not usable during Power Down.

Configuration and Test

Configuration is the process of loading design-specific programming data into one or more FPGAs to define the functional operation of the internal blocks and their interconnections. This is somewhat like loading the command registers of a programmable peripheral chip. Spartan/XL devices use several hundred bits of configuration data per CLB and its associated interconnects. Each configuration bit defines the state of a static memory cell

that controls either a function look-up table bit, a multiplexer input, or an interconnect pass transistor. The Xilinx development system translates the design into a netlist file. It automatically partitions, places and routes the logic and generates the configuration data in PROM format.

Configuration Mode Control

5V Spartan devices have two configuration modes.

- MODE = 1 sets Slave Serial mode
- MODE = 0 sets Master Serial mode

3V Spartan-XL devices have three configuration modes.

- M1/M0 = 11 sets Slave Serial mode
- M1/M0 = 10 sets Master Serial mode
- M1/M0 = 0X sets Express mode

In addition to these modes, the device can be configured through the Boundary Scan logic (See "Configuration Through the Boundary Scan Pins" on page 37.).

The Mode pins are sampled prior to starting configuration to determine the configuration mode. After configuration, these pin are unused. The Mode pins have a weak pull-up resistor turned on during configuration. With the Mode pins High, Slave Serial mode is selected, which is the most popular configuration mode. Therefore, for the most common configuration mode, the Mode pins can be left unconnected. If the Master Serial mode is desired, the MODE/M0 pin should be connected directly to GND, or through a pull-down resistor of 1 K Ω or less.

During configuration, some of the I/O pins are used temporarily for the configuration process. All pins used during con-



Slave Serial is the default mode if the Mode pins are left unconnected, as they have weak pull-up resistors during configuration.

Multiple slave devices with identical configurations can be wired with parallel DIN inputs. In this way, multiple devices can be configured simultaneously.

Serial Daisy Chain

Multiple devices with different configurations can be connected together in a "daisy chain," and a single combined bitstream used to configure the chain of slave devices.

To configure a daisy chain of devices, wire the CCLK pins of all devices in parallel, as shown in Figure 25. Connect the DOUT of each device to the DIN of the next. The lead or master FPGA and following slaves each passes resynchronized configuration data coming from a single source. The header data, including the length count, is passed through

and is captured by each FPGA when it recognizes the 0010 preamble. Following the length-count data, each FPGA outputs a High on DOUT until it has received its required number of data frames.

After an FPGA has received its configuration data, it passes on any additional frame start bits and configuration data on DOUT. When the total number of configuration clocks applied after memory initialization equals the value of the 24-bit length count, the FPGAs begin the start-up sequence and become operational together. FPGA I/O are normally released two CCLK cycles after the last configuration bit is received.

The daisy-chained bitstream is not simply a concatenation of the individual bitstreams. The PROM File Formatter must be used to combine the bitstreams for a daisy-chained configuration.

Note:

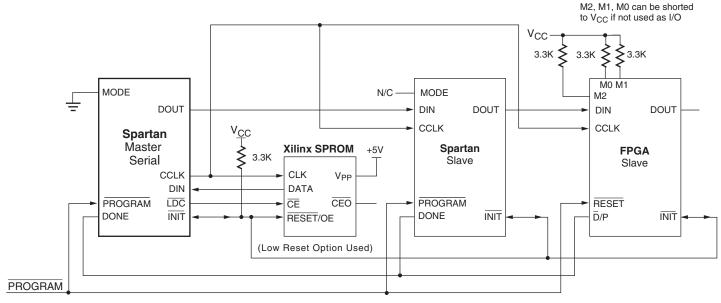
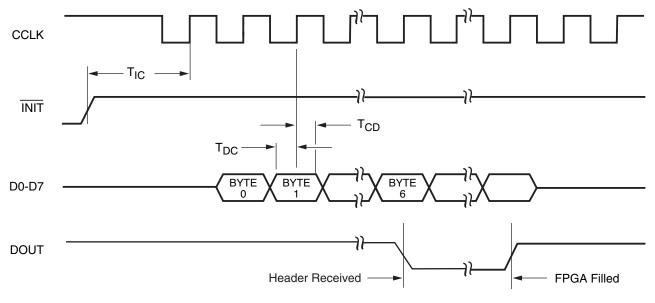


Figure 25: Master/Slave Serial Mode Circuit Diagram

DS060_25_061301





DS060_28_080400

Symbol		Description	Min	Max	Units
T _{IC}		INIT (High) setup time	5	-	μs
T _{DC}		D0-D7 setup time	20	-	ns
T _{CD}	CCLK	D0-D7 hold time	0	-	ns
T _{CCH}	COLK	CCLK High time	45	-	ns
T _{CCL}		CCLK Low time	45	-	ns
F _{CC}		CCLK Frequency	-	10	MHz

Notes:

Figure 28: Express Mode Programming Switching Characteristics

Setting CCLK Frequency

In Master mode, CCLK can be generated in either of two frequencies. In the default slow mode, the frequency ranges from 0.5 MHz to 1.25 MHz for Spartan/XL devices. In fast CCLK mode, the frequency ranges from 4 MHz to 10 MHz for Spartan/XL devices. The frequency is changed to fast by an option when running the bitstream generation software.

Data Stream Format

The data stream ("bitstream") format is identical for both serial configuration modes, but different for the Spartan-XL family Express mode. In Express mode, the device becomes active when DONE goes High, therefore no length count is required. Additionally, CRC error checking is not supported in Express mode. The data stream format is shown in Table 16. Bit-serial data is read from left to right.

Express mode data is shown with D0 at the left and D7 at the right.

The configuration data stream begins with a string of eight ones, a preamble code, followed by a 24-bit length count and a separator field of ones (or 24 fill bits, in Spartan-XL family Express mode). This header is followed by the actual configuration data in frames. The length and number of frames depends on the device type (see Table 17). Each frame begins with a start field and ends with an error check. In serial modes, a postamble code is required to signal the end of data for a single device. In all cases, additional start-up bytes of data are required to provide four clocks for the startup sequence at the end of configuration. Long daisy chains require additional start-up bytes to shift the last data through the chain. All start-up bytes are "don't cares".

If not driven by the preceding DOUT, CS1 must remain High until the device is fully configured.



Table 16: Spartan/XL Data Stream Formats

Data Type	Serial Modes (D0)	Express Mode (D0-D7) (Spartan-XL only)
Fill Byte	11111111b	FFFFh
Preamble Code	0010b	11110010b
Length Count	COUNT[23:0]	COUNT[23:0] ⁽¹⁾
Fill Bits	1111b	-
Field Check Code	-	11010010b
Start Field	0b	11111110b ⁽²⁾
Data Frame	DATA[n-1:0]	DATA[n-1:0]
CRC or Constant Field Check	xxxx (CRC) or 0110b	11010010b
Extend Write Cycle	-	FFD2FFFFFh
Postamble	01111111b	-
Start-Up Bytes ⁽³⁾	FFh	FFFFFFFFFF

Legend:

Unshaded	Once per bitstream
Light	Once per data frame
Dark	Once per device

Notes:

- 1. Not used by configuration logic.
- 2. 11111111b for XCS40XL only.
- 3. Development system may add more start-up bytes.

A selection of CRC or non-CRC error checking is allowed by the bitstream generation software. The Spartan-XL family Express mode only supports non-CRC error checking. The non-CRC error checking tests for a designated end-of-frame field for each frame. For CRC error checking, the software calculates a running CRC and inserts a unique four-bit partial check at the end of each frame. The 11-bit CRC check of the last frame of an FPGA includes the last seven data bits.

Detection of an error results in the suspension of data loading before DONE goes High, and the pulling down of the $\overline{\text{INIT}}$ pin. In Master serial mode, CCLK continues to operate externally. The user must detect $\overline{\text{INIT}}$ and initialize a new configuration by pulsing the $\overline{\text{PROGRAM}}$ pin Low or cycling V_{CC} .

Cyclic Redundancy Check (CRC) for Configuration and Readback

The Cyclic Redundancy Check is a method of error detection in data transmission applications. Generally, the transmitting system performs a calculation on the serial bitstream. The result of this calculation is tagged onto the data stream as additional check bits. The receiving system performs an identical calculation on the bitstream and compares the result with the received checksum.

Each data frame of the configuration bitstream has four error bits at the end, as shown in Table 16. If a frame data error is detected during the loading of the FPGA, the configuration process with a potentially corrupted bitstream is terminated. The FPGA pulls the INIT pin Low and goes into a Wait state.



Spartan-XL Family DC Characteristics Over Operating Conditions

Symbol	Description		Min	Тур.	Max	Units
V _{OH}	High-level output voltage @ $I_{OH} = -4.0 \text{ mA}$, $V_{CC} \text{ min (LVTTL)}$		2.4	-	-	V
	High-level output voltage @ $I_{OH} = -500 \mu A$, (LV	n-level output voltage @ I _{OH} = -500 μA, (LVCMOS)		-	-	V
V _{OL}	Low-level output voltage @ I _{OL} = 12.0 mA, V _{CO}	; min (LVTTL) ⁽¹⁾	-	-	0.4	V
	Low-level output voltage @ I _{OL} = 24.0 mA, V _{CO}	; min (LVTTL) ⁽²⁾	-	-	0.4	V
	Low-level output voltage @ I _{OL} = 1500 μA, (LV	CMOS)	-	-	10% V _{CC}	V
V _{DR}	Data retention supply voltage (below which cormay be lost)	retention supply voltage (below which configuration data be lost)		-	-	V
I _{CCO}	Quiescent FPGA supply current ^(3,4)	Commercial	-	0.1	2.5	mA
		Industrial	-	0.1	5	mA
I _{CCPD}	Power Down FPGA supply current ^(3,5)	Commercial	-	0.1	2.5	mA
		Industrial	-	0.1	5	mA
IL	Input or output leakage current		-10	-	10	μΑ
C _{IN}	Input capacitance (sample tested)		-	-	10	pF
I _{RPU}	Pad pull-up (when selected) @ V _{IN} = 0V (sample tested)		0.02	-	0.25	mA
I _{RPD}	Pad pull-down (when selected) @ V _{IN} = 3.3V (s	sample tested)	0.02	-	-	mA

Notes:

- With up to 64 pins simultaneously sinking 12 mA (default mode).
- 2. With up to 64 pins simultaneously sinking 24 mA (with 24 mA option selected).
- 3. With 5V tolerance not selected, no internal oscillators, and the FPGA configured with the Tie option.
- With no output current loads, no active input resistors, and all package pins at V_{CC} or GND.
- 5. With PWRDWN active.

Supply Current Requirements During Power-On

Spartan-XL FPGAs require that a minimum supply current I_{CCPO} be provided to the V_{CC} lines for a successful power on. If more current is available, the FPGA can consume more than I_{CCPO} min., though this cannot adversely affect reliability.

A maximum limit for I_{CCPO} is not specified. Be careful when using foldback/crowbar supplies and fuses. It is possible to control the magnitude of I_{CCPO} by limiting the supply current available to the FPGA. A current limit below the trip level will avoid inadvertently activating over-current protection circuits.

Symbol	Description	Min	Max	Units
I _{CCPO}	Total V _{CC} supply current required during power-on	100	-	mA
T _{CCPO}	V _{CC} ramp time ^(2,3)	-	50	ms

Notes:

- 1. The I_{CCPO} requirement applies for a brief time (commonly only a few milliseconds) when V_{CC} ramps from 0 to 3.3V.
- 2. The ramp time is measured from GND to V_{CC} max on a fully loaded board.
- V_{CC} must not dip in the negative direction during power on.



Spartan-XL Family CLB Switching Characteristic Guidelines

All devices are 100% functionally tested. Internal timing parameters are derived from measuring internal test patterns. Listed below are representative values. For more specific, more precise, and worst-case guaranteed data, use the values reported by the static timing analyzer (TRCE

in the Xilinx Development System) and back-annotated to the simulation netlist. All timing parameters assume worst-case operating conditions (supply voltage and junction temperature). Values apply to all Spartan-XL devices and expressed in nanoseconds unless otherwise noted.

			Speed	Grade		
		-5		-4		1
Symbol	Description	Min	Max	Min	Max	Units
Clocks						
T _{CH}	Clock High time	2.0	-	2.3	-	ns
T _{CL}	Clock Low time	2.0	-	2.3	-	ns
Combinato	orial Delays		,	1	ı	
T _{ILO}	F/G inputs to X/Y outputs	-	1.0	-	1.1	ns
T _{IHO}	F/G inputs via H to X/Y outputs	-	1.7	-	2.0	ns
T _{ITO}	F/G inputs via transparent latch to Q outputs	-	1.5	-	1.8	ns
T _{HH1O}	C inputs via H1 via H to X/Y outputs	-	1.5	-	1.8	ns
Sequentia	l Delays	*			,	
T _{CKO}	Clock K to Flip-Flop or latch outputs Q	-	1.2	-	1.4	ns
Setup Tim	e before Clock K		,		ı	
T _{ICK}	F/G inputs	0.6	-	0.7	-	ns
T _{IHCK}	F/G inputs via H	1.3	-	1.6	-	ns
Hold Time	after Clock K	*			,	
	All Hold times, all devices	0.0	-	0.0	-	ns
Set/Reset	Direct					
T _{RPW}	Width (High)	2.5	-	2.8	-	ns
T _{RIO}	Delay from C inputs via S/R, going High to Q	-	2.3	-	2.7	ns
Global Set	Reset	*			,	
T_{MRW}	Minimum GSR Pulse Width	10.5	-	11.5	-	ns
T_{MRQ}	Delay from GSR input to any Q	See page 60 for T _{RRI} values per device.			r device.	
F _{TOG}	Toggle Frequency (MHz) (for export control purposes)	-	250	-	217	MHz



Spartan-XL Family Pin-to-Pin Input Parameter Guidelines

All devices are 100% functionally tested. Pin-to-pin timing parameters are derived from measuring external and internal test patterns and are guaranteed over worst-case oper-

ating conditions (supply voltage and junction temperature). Listed below are representative values for typical pin locations and normal clock loading.

Spartan-XL Family Setup and Hold

	Speed Grade			Grade		
			-5	-4		
Symbol	Description	Device	Max	Max	Units	
Input Setup/Hold Times Using Global Clock and IFF						
T _{SUF} /T _{HF}	No Delay	XCS05XL	1.1/2.0	1.6/2.6	ns	
		XCS10XL	1.0/2.2	1.5/2.8	ns	
		XCS20XL	0.9/2.4	1.4/3.0	ns	
		XCS30XL	0.8/2.6	1.3/3.2	ns	
		XCS40XL	0.7/2.8	1.2/3.4	ns	
T _{SU} /T _H	Full Delay	XCS05XL	3.9/0.0	5.1/0.0	ns	
		XCS10XL	4.1/0.0	5.3/0.0	ns	
		XCS20XL	4.3/0.0	5.5/0.0	ns	
		XCS30XL	4.5/0.0	5.7/0.0	ns	
		XCS40XL	4.7/0.0	5.9/0.0	ns	

Notes:

- 1. IFF = Input Flip-Flop or Latch
- 2. Setup time is measured with the fastest route and the lightest load. Hold time is measured using the furthest distance and a reference load of one clock pin per IOB/CLB.

Capacitive Load Factor

Figure 35 shows the relationship between I/O output delay and load capacitance. It allows a user to adjust the specified output delay if the load capacitance is different than 50 pF. For example, if the actual load capacitance is 120 pF, add 2.5 ns to the specified delay. If the load capacitance is 20 pF, subtract 0.8 ns from the specified output delay. Figure 35 is usable over the specified operating conditions of voltage and temperature and is independent of the output slew rate control.

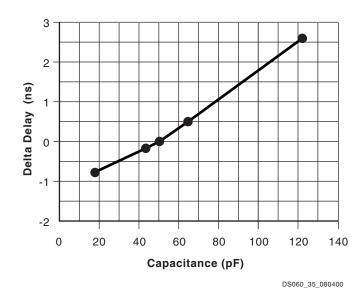


Figure 35: Delay Factor at Various Capacitive Loads



Spartan-XL Family IOB Output Switching Characteristic Guidelines

All devices are 100% functionally tested. Internal timing parameters are derived from measuring internal test patterns. Listed below are representative values. For more specific, more precise, and worst-case guaranteed data, use the values reported by the static timing analyzer (TRCE in the Xilinx Development System) and back-annotated to

the simulation netlist. These path delays, provided as a guideline, have been extracted from the static timing analyzer report. All timing parameters assume worst-case operating conditions (supply voltage and junction temperature). Values are expressed in nanoseconds unless otherwise noted.

				Speed	Grade		
			-	5		4	
Symbol	Description	Device	Min	Max	Min	Max	Units
Propagation	Delays						
T _{OKPOF}	Clock (OK) to Pad, fast	All devices	-	3.2	-	3.7	ns
T _{OPF}	Output (O) to Pad, fast	All devices	-	2.5	-	2.9	ns
T _{TSHZ}	3-state to Pad High-Z (slew-rate independent)	All devices	-	2.8	-	3.3	ns
T _{TSONF}	3-state to Pad active and valid, fast	All devices	-	2.6	-	3.0	ns
T _{OFPF}	Output (O) to Pad via Output MUX, fast	All devices	-	3.7	-	4.4	ns
T _{OKFPF}	Select (OK) to Pad via Output MUX, fast	All devices	-	3.3	-	3.9	ns
T _{SLOW}	For Output SLOW option add	All devices	-	1.5	-	1.7	ns
Setup and H	old Times		,				
T _{OOK}	Output (O) to clock (OK) setup time	All devices	0.5	-	0.5	-	ns
T _{OKO}	Output (O) to clock (OK) hold time	All devices	0.0	-	0.0	-	ns
T _{ECOK}	Clock Enable (EC) to clock (OK) setup time	All devices	0.0	-	0.0	-	ns
T _{OKEC}	Clock Enable (EC) to clock (OK) hold time	All devices	0.1	-	0.2	-	ns
Global Set/R	eset						
T_{MRW}	Minimum GSR pulse width	All devices	10.5	-	11.5	-	ns
T _{RPO}	Delay from GSR input to any Pad	XCS05XL	-	11.9	-	14.0	ns
		XCS10XL	-	12.4	-	14.5	ns
		XCS20XL	-	12.9	-	15.0	ns
		XCS30XL	-	13.9	-	16.0	ns
		XCS40XL	-	14.9	-	17.0	ns

Notes:

^{1.} Output timing is measured at \sim 50% V_{CC} threshold, with 50 pF external capacitive loads including test fixture. Slew-rate limited output rise/fall times are approximately two times longer than fast output rise/fall times.

^{2.} Voltage levels of unused pads, bonded or unbonded, must be valid logic levels. Each can be configured with the internal pull-up (default) or pull-down resistor, or configured as a driven output, or can be driven from an external source.



Device-Specific Pinout Tables

Device-specific tables include all packages for each Spartan and Spartan-XL device. They follow the pad locations around the die, and include boundary scan register locations.

Some Spartan-XL devices are available in Pb-free package options. The Pb-free package options have the same pinouts as the standard package options.

XCS05 and XCS05XL Device Pinouts

XCS05/XL	(A)		Bndry
Pad Name	PC84 ⁽⁴⁾	VQ100	Scan
VCC	P2	P89	-
I/O	P3	P90	32
I/O	P4	P91	35
I/O	-	P92	38
I/O	-	P93	41
I/O	P5	P94	44
I/O	P6	P95	47
I/O	P7	P96	50
I/O	P8	P97	53
I/O	P9	P98	56
I/O, SGCK1 ⁽¹⁾ , GCK8 ⁽²⁾	P10	P99	59
VCC	P11	P100	-
GND	P12	P1	-
I/O, PGCK1 ⁽¹⁾ , GCK1 ⁽²⁾	P13	P2	62
I/O	P14	P3	65
I/O, TDI	P15	P4	68
I/O, TCK	P16	P5	71
I/O, TMS	P17	P6	74
I/O	P18	P7	77
I/O	-	P8	83
I/O	P19	P9	86
I/O	P20	P10	89
GND	P21	P11	-
VCC	P22	P12	-
I/O	P23	P13	92
I/O	P24	P14	95
I/O	-	P15	98
I/O	P25	P16	104
I/O	P26	P17	107
I/O	P27	P18	110
I/O	-	P19	113
I/O	P28	P20	116
I/O, SGCK2 ⁽¹⁾ , GCK2 ⁽²⁾	P29	P21	119
Not Connected ⁽¹⁾ , M1 ⁽²⁾	P30	P22	122
GND	P31	P23	-
MODE ⁽¹⁾ , M0 ⁽²⁾	P32	P24	125
VCC	P33	P25	-
1	1		I.

XCS05 and XCS05XL Device Pinouts

XCS05/XL Pad Name	PC84 ⁽⁴⁾	VQ100	Bndry Scan
Not Connected ⁽¹⁾ ,	P34	P26	126 ⁽¹⁾
PWRDWN ⁽²⁾		F20	
I/O, PGCK2 ⁽¹⁾ , GCK3 ⁽²⁾	P35	P27	127 ⁽³⁾
I/O (HDC)	P36	P28	130 ⁽³⁾
I/O	-	P29	133 ⁽³⁾
I/O (LDC)	P37	P30	136 ⁽³⁾
I/O	P38	P31	139 ⁽³⁾
I/O	P39	P32	142 ⁽³⁾
I/O	-	P33	145 ⁽³⁾
I/O	-	P34	148 ⁽³⁾
I/O	P40	P35	151 ⁽³⁾
I/O (ĪNĪT)	P41	P36	154 ⁽³⁾
VCC	P42	P37	-
GND	P43	P38	-
I/O	P44	P39	157 ⁽³⁾
I/O	P45	P40	160 ⁽³⁾
I/O	-	P41	163 ⁽³⁾
I/O	-	P42	166 ⁽³⁾
I/O	P46	P43	169 ⁽³⁾
I/O	P47	P44	172 ⁽³⁾
I/O	P48	P45	175 ⁽³⁾
I/O	P49	P46	178 ⁽³⁾
I/O	P50	P47	181 ⁽³⁾
I/O, SGCK3 ⁽¹⁾ , GCK4 ⁽²⁾	P51	P48	184 ⁽³⁾
GND	P52	P49	-
DONE	P53	P50	-
VCC	P54	P51	-
PROGRAM	P55	P52	- (0)
I/O (D7 ⁽²⁾)	P56	P53	187 ⁽³⁾
I/O, PGCK3 ⁽¹⁾ , GCK5 ⁽²⁾	P57	P54	190 ⁽³⁾
I/O (D6 ⁽²⁾)	P58	P55	193 ⁽³⁾
I/O	-	P56	196 ⁽³⁾
I/O (D5 ⁽²⁾)	P59	P57	199 ⁽³⁾
I/O	P60	P58	202 ⁽³⁾
I/O	-	P59	205 ⁽³⁾
I/O	-	P60	208 ⁽³⁾
I/O (D4 ⁽²⁾)	P61	P61	211(3)
1/0	P62	P62	214 ⁽³⁾
VCC	P63	P63	-
GND	P64	P64	-
I/O (D3 ⁽²⁾)	P65	P65	217 ⁽³⁾
1/0	P66	P66	220(3)
1/0	-	P67	223 ⁽³⁾
I/O (D2 ⁽²⁾)	P67	P68	229 ⁽³⁾
1/0	P68	P69	232 ⁽³⁾
I/O (D1 ⁽²⁾)	P69	P70	235 ⁽³⁾



XCS10 and XCS10XL Device Pinouts

XCS10/XL Pad Name	PC84 ⁽⁴⁾	VQ100	CS144 ^(2,4)	TQ144	Bndry Scan
I/O	P80	P81	A10	P116	17
GND	-	-	C9	P118	-
I/O	-	-	B9	P119	20
I/O	-	-	A9	P120	23
I/O	P81	P82	D8	P121	26
I/O	P82	P83	C8	P122	29
I/O	-	P84	B8	P123	32
I/O	-	P85	A8	P124	35
I/O	P83	P86	B7	P125	38
I/O	P84	P87	A7	P126	41
GND	P1	P88	C7	P127	-

Notes:

- 1. 5V Spartan family only
- 2. 3V Spartan-XL family only
- 3. The "PWRDWN" on the XCS10XL is not part of the Boundary Scan chain. For the XCS10XL, subtract 1 from all Boundary Scan numbers from GCK3 on (175 and higher).
- 4. PC84 and CS144 packages discontinued by PDN2004-01

Additional XCS10/XL Package Pins

TQ144									
Not Connected Pins									
P117	-	-	-	-	-				
5/5/97									

CS144									
Not Connected Pins									
D9	-	-	-	-	-				
4/28/99									

XCS20 and XCS20XL Device Pinouts

XCS20/XL					Bndry
Pad Name	VQ100	CS144 ^(2,4)	TQ144	PQ208	Scan
VCC	P89	D7	P128	P183	-
I/O	P90	A6	P129	P184	62
I/O	P91	B6	P130	P185	65
I/O	P92	C6	P131	P186	68
I/O	P93	D6	P132	P187	71
I/O	-	-	-	P188	74
I/O	-	-	-	P189	77
I/O	P94	A5	P133	P190	80
I/O	P95	B5	P134	P191	83
VCC ⁽²⁾	-	-	-	P192	-
I/O	-	C5	P135	P193	86
I/O	-	D5	P136	P194	89
GND	-	A4	P137	P195	-
I/O	-	-	-	P196	92
I/O	-	-	-	P197	95
I/O	-	-	-	P198	98
I/O	-	-	-	P199	101
I/O	P96	B4	P138	P200	104
I/O	P97	C4	P139	P201	107
I/O	-	А3	P140	P204	110
I/O	-	B3	P141	P205	113
I/O	P98	C3	P142	P206	116

XCS20 and XCS20XL Device Pinouts

XCS20/XL	V0400	CS144 ^(2,4)	TO444	DOGGG	Bndry
Pad Name	VQ100		TQ144	PQ208	Scan
I/O, SGCK1 ⁽¹⁾ , GCK8 ⁽²⁾	P99	A2	P143	P207	119
VCC	P100	B2	P144	P208	-
GND	P1	A1	P1	P1	-
I/O, PGCK1 ⁽¹⁾ , GCK1 ⁽²⁾	P2	B1	P2	P2	122
I/O	P3	C2	P3	P3	125
I/O	-	C1	P4	P4	128
I/O	-	D4	P5	P5	131
I/O, TDI	P4	D3	P6	P6	134
I/O, TCK	P5	D2	P7	P7	137
I/O	-	-	-	P8	140
I/O	-	-	-	P9	143
I/O	-	-	-	P10	146
I/O	-	-	-	P11	149
GND	-	D1	P8	P13	-
I/O	-	E4	P9	P14	152
I/O	-	E3	P10	P15	155
I/O, TMS	P6	E2	P11	P16	158
I/O	P7	E1	P12	P17	161
VCC ⁽²⁾	-	-	-	P18	-
I/O	-	-	-	P19	164
I/O	-	-	-	P20	167



XCS20 and XCS20XL Device Pinouts

	and XCS2UXL Device Pinouts							
XCS20/XL Pad Name	VQ100	CS144 ^(2,4)	TQ144	PQ208	Bndry Scan			
PROGRAM	P52	M13	P74	P106	-			
I/O (D7 ⁽²⁾)	P53	L12	P75	P107	367 ⁽³⁾			
I/O,	P54	L13	P76	P108	370 ⁽³⁾			
PGCK3 ⁽¹⁾ , GCK5 ⁽²⁾								
I/O		K10	P77	P109	373 ⁽³⁾			
1/0	-	K10	P77	P109	373 ⁽³⁾			
I/O (D6 ⁽²⁾)	- P55	K11	P79	P110	379 ⁽³⁾			
I/O (D6(=/)		K12		P112	382 (3)			
	P56	NIS	P80		385 (3)			
1/0	-	-	-	P114				
1/0	-	-	-	P115	388 (3)			
1/0	-	-	-	P116	391 ⁽³⁾			
I/O	-	-	-	P117	394 ⁽³⁾			
GND	-	J10	P81	P118	- (2)			
I/O	-	J11	P82	P119	397 ⁽³⁾			
I/O	-	J12	P83	P120	400 (3)			
VCC ⁽²⁾	-	-	-	P121	- (0)			
I/O (D5 ⁽²⁾)	P57	J13	P84	P122	403 (3)			
I/O	P58	H10	P85	P123	406 ⁽³⁾			
I/O	-	-	-	P124	409 (3)			
I/O	-	-	-	P125	412 ⁽³⁾			
I/O	P59	H11	P86	P126	415 ⁽³⁾			
I/O	P60	H12	P87	P127	418 ⁽³⁾			
I/O (D4 ⁽²⁾)	P61	H13	P88	P128	421 ⁽³⁾			
I/O	P62	G12	P89	P129	424 ⁽³⁾			
VCC	P63	G13	P90	P130	-			
GND	P64	G11	P91	P131	-			
I/O (D3 ⁽²⁾)	P65	G10	P92	P132	427 ⁽³⁾			
I/O	P66	F13	P93	P133	430 ⁽³⁾			
I/O	P67	F12	P94	P134	433 ⁽³⁾			
I/O	-	F11	P95	P135	436 ⁽³⁾			
I/O	-	-	-	P136	439 ⁽³⁾			
I/O	-	-	-	P137	442 (3)			
I/O (D2 ⁽²⁾)	P68	F10	P96	P138	445 ⁽³⁾			
I/O	P69	E13	P97	P139	448 ⁽³⁾			
VCC ⁽²⁾	-	-	-	P140	-			
I/O	_	E12	P98	P141	451 ⁽³⁾			
I/O	_	E11	P99	P142	454 ⁽³⁾			
GND	-	E10	P100	P143	-			
I/O	-	-	-	P145	457 ⁽³⁾			
I/O	-	-	-	P146	460 ⁽³⁾			
I/O	-	-	-	P147	463 ⁽³⁾			
I/O	-	-	-	P148	466 ⁽³⁾			
I/O (D1 ⁽²⁾)	P70	D13	P101	P149	469 ⁽³⁾			
I/O	P71	D12	P102	P150	472 ⁽³⁾			
I/O	-	D11	P103	P151	475 ⁽³⁾			

XCS20 and XCS20XL Device Pinouts

XCS20/XL Pad Name	VQ100	CS144 ^(2,4)	TQ144	PQ208	Bndry Scan
I/O	-	C13	P104	P152	478 ⁽³⁾
I/O (D0 ⁽²⁾ , DIN)	P72	C12	P105	P153	481 ⁽³⁾
I/O, SGCK4 ⁽¹⁾ , GCK6 ⁽²⁾ (DOUT)	P73	C11	P106	P154	484 ⁽³⁾
CCLK	P74	B13	P107	P155	-
VCC	P75	B12	P108	P156	-
O, TDO	P76	A13	P109	P157	0
GND	P77	A12	P110	P158	-
I/O	P78	B11	P111	P159	2
I/O, PGCK4 ⁽¹⁾ , GCK7 ⁽²⁾	P79	A11	P112	P160	5
I/O	-	D10	P113	P161	8
I/O	-	C10	P114	P162	11
I/O (CS1 ⁽²⁾)	P80	B10	P115	P163	14
I/O	P81	A10	P116	P164	17
I/O	-	D9	P117	P166	20
I/O	-	-	-	P167	23
I/O	-	-	-	P168	26
I/O	-	-	-	P169	29
GND	-	C9	P118	P170	-
I/O	-	B9	P119	P171	32
I/O	-	A9	P120	P172	35
VCC ⁽²⁾	-	-	-	P173	-
I/O	P82	D8	P121	P174	38
I/O	P83	C8	P122	P175	41
I/O	-	-	-	P176	44
I/O	-	-	-	P177	47
I/O	P84	B8	P123	P178	50
I/O	P85	A8	P124	P179	53
I/O	P86	B7	P125	P180	56
I/O	P87	A7	P126	P181	59
GND	P88	C7	P127	P182	-

2/8/00



Additional XCS20/XL Package Pins

PQ208										
	Not Connected Pins									
P12	P12 P18 ⁽¹⁾ P33 ⁽¹⁾ P39 P65 P71 ⁽¹⁾									
P86 ⁽¹⁾	P92	P111	P121 ⁽¹⁾	P140 ⁽¹⁾	P144					
P165	P173 ⁽¹⁾	P192 ⁽¹⁾	P202	P203	-					
9/16/98										

Notes:

- 1. 5V Spartan family only
- 2. 3V Spartan-XL family only
- The "PWRDWN" on the XCS20XL is not part of the Boundary Scan chain. For the XCS20XL, subtract 1 from all Boundary Scan numbers from GCK3 on (247 and higher).
- 4. CS144 package discontinued by PDN2004-01

XCS30 and XCS30XL Device Pinouts

XCS30/XL Pad Name	VQ100 ⁽⁵⁾	TQ144	PQ208	PQ240	BG256 ⁽⁵⁾	CS280 ^(2,5)	Bndry Scan
VCC	P89	P128	P183	P212	VCC ⁽⁴⁾	C10	-
I/O	P90	P129	P184	P213	C10	D10	74
I/O	P91	P130	P185	P214	D10	E10	77
I/O	P92	P131	P186	P215	A9	A9	80
I/O	P93	P132	P187	P216	B9	В9	83
I/O	-	-	P188	P217	C9	C9	86
I/O	-	-	P189	P218	D9	D9	89
I/O	P94	P133	P190	P220	A8	A8	92
I/O	P95	P134	P191	P221	B8	B8	95
VCC	-	-	P192	P222	VCC ⁽⁴⁾	A7	-
I/O	-	-	-	P223	A6	B7	98
I/O	-	-	-	P224	C7	C7	101
I/O	-	P135	P193	P225	B6	D7	104
I/O	-	P136	P194	P226	A5	A6	107
GND	-	P137	P195	P227	GND ⁽⁴⁾	GND ⁽⁴⁾	-
I/O	-	-	P196	P228	C6	В6	110
I/O	-	-	P197	P229	B5	C6	113
I/O	-	-	P198	P230	A4	D6	116
I/O	-	-	P199	P231	C5	E6	119
I/O	P96	P138	P200	P232	B4	A 5	122
I/O	P97	P139	P201	P233	A3	C5	125
I/O	-	-	P202	P234	D5	B4	128
I/O	-	-	P203	P235	C4	C4	131
I/O	-	P140	P204	P236	В3	A3	134
I/O	-	P141	P205	P237	B2	A2	137
I/O	P98	P142	P206	P238	A2	В3	140
I/O, SGCK1 ⁽¹⁾ , GCK8 ⁽²⁾	P99	P143	P207	P239	СЗ	B2	143
VCC	P100	P144	P208	P240	VCC ⁽⁴⁾	A1	-
GND	P1	P1	P1	P1	GND ⁽⁴⁾	GND ⁽⁴⁾	-
I/O, PGCK1 ⁽¹⁾ , GCK1 ⁽²⁾	P2	P2	P2	P2	B1	C3	146
I/O	P3	P3	P3	P3	C2	C2	149
I/O	-	P4	P4	P4	D2	B1	152



XCS40 and XCS40XL Device Pinouts

XC540 and	I AUS4	OVE D	FVICE P	illouis	
XCS40/XL Pad Name	PQ208	PQ240	BG256	CS280 ^(2,5)	Bndry Scan
I/O	P90	P105	Y16	W14	466 ⁽³⁾
GND	P91	P106	GND ⁽⁴⁾	GND ⁽⁴⁾	-
I/O	-	P107	V15	V14	469 ⁽³⁾
I/O	P92	P108	W16	U14	472 ⁽³⁾
I/O	P93	P109	Y17	T14	475 ⁽³⁾
I/O	P94	P110	V16	R14	478 ⁽³⁾
I/O	P95	P111	W17	W15	481 ⁽³⁾
I/O	P96	P112	Y18	U15	484 (3)
I/O	-	-	-	T15	487 ⁽³⁾
I/O	-	-	-	W16	490 (3)
I/O	P97	P113	U16	V16	493 (3)
I/O	P98	P114	V17	U16	496 ⁽³⁾
I/O	P99	P115	W18	W17	499 (3)
I/O	P100	P116	Y19	W18	502 ⁽³⁾
I/O	P101	P117	V18	V17	505 ⁽³⁾
I/O,	P102	P118	W19	V18	508 ⁽³⁾
SGCK3 ⁽¹⁾ ,					
GCK4 ⁽²⁾					
GND	P103	P119	GND ⁽⁴⁾	GND ⁽⁴⁾	-
DONE	P104	P120	Y20	W19	-
VCC	P105	P121	VCC ⁽⁴⁾	VCC ⁽⁴⁾	-
PROGRAM	P106	P122	V19	U18	-
I/O (D7 ⁽²⁾)	P107	P123	U19	V19	511 ⁽³⁾
I/O,	P108	P124	U18	U19	514 ⁽³⁾
PGCK3 ⁽¹⁾ , GCK5 ⁽²⁾					
I/O	P109	P125	T17	T16	517 ⁽³⁾
I/O	P110	P126	V20	T17	520 ⁽³⁾
I/O	-	P127	U20	T18	523 ⁽³⁾
I/O	P111	P128	T18	T19	526 ⁽³⁾
I/O	_	-	-	R15	529 ⁽³⁾
I/O	-	-	-	R17	523 ⁽³⁾
I/O (D6 ⁽²⁾)	P112	P129	T19	R16	535 ⁽³⁾
I/O	P113	P130	T20	R19	538 ⁽³⁾
I/O	P114	P131	R18	P15	541 ⁽³⁾
I/O	P115	P132	R19	P17	544 (3)
I/O	P116	P133	R20	P18	547 ⁽³⁾
I/O	P117	P134	P18	P16	550 ⁽³⁾
GND	P118	P135	GND ⁽⁴⁾	GND ⁽⁴⁾	-
I/O		P136	P20	P19	553 ⁽³⁾
I/O	_	P137	N18	N17	556 ⁽³⁾
I/O	P119	P138	N19	N18	559 ⁽³⁾
I/O	P120	P139	N20	N19	562 ⁽³⁾
VCC	P121	P140	VCC ⁽⁴⁾	VCC ⁽⁴⁾	502 ()
I/O (D5 ⁽²⁾)	P122	P140	M17	M19	565 ⁽³⁾
I/O (D3(=/)	P123	P141	M18	M17	568 ⁽³⁾
"0	1 123	1 142	IVI I O	IVI I /	JU0 (°)

XCS40 and XCS40XL Device Pinouts

XCS40/XL Pad Name	PQ208	PQ240	BG256	CS280 ^(2,5)	Bndry Scan
I/O	-	-	-	M18	571 ⁽³⁾
I/O	-	-	M19	M16	574 ⁽³⁾
I/O	P124	P144	M20	L19	577 ⁽³⁾
I/O	P125	P145	L19	L18	580 ⁽³⁾
I/O	P126	P146	L18	L17	583 ⁽³⁾
I/O	P127	P147	L20	L16	586 ⁽³⁾
I/O (D4 ⁽²⁾)	P128	P148	K20	K19	589 ⁽³⁾
I/O	P129	P149	K19	K18	592 ⁽³⁾
VCC	P130	P150	VCC ⁽⁴⁾	VCC ⁽⁴⁾	-
GND	P131	P151	GND ⁽⁴⁾	GND ⁽⁴⁾	-
I/O (D3 ⁽²⁾)	P132	P152	K18	K16	595 ⁽³⁾
I/O	P133	P153	K17	K15	598 ⁽³⁾
I/O	P134	P154	J20	J19	601 ⁽³⁾
I/O	P135	P155	J19	J18	604 ⁽³⁾
I/O	P136	P156	J18	J17	607 ⁽³⁾
I/O	P137	P157	J17	J16	610 ⁽³⁾
I/O	-	-	H20	H19	613 ⁽³⁾
I/O	-	-	-	H18	616 ⁽³⁾
I/O (D2 ⁽²⁾)	P138	P159	H19	H17	619 ⁽³⁾
I/O	P139	P160	H18	H16	622 ⁽³⁾
VCC	P140	P161	VCC ⁽⁴⁾	VCC ⁽⁴⁾	-
I/O	P141	P162	G19	G18	625 ⁽³⁾
I/O	P142	P163	F20	G17	628 ⁽³⁾
I/O	-	P164	G18	G16	631 ⁽³⁾
I/O	-	P165	F19	F19	634 ⁽³⁾
GND	P143	P166	GND ⁽⁴⁾	GND ⁽⁴⁾	-
I/O	-	P167	F18	F18	637 ⁽³⁾
I/O	P144	P168	E19	F17	640 ⁽³⁾
I/O	P145	P169	D20	F16	643 ⁽³⁾
I/O	P146	P170	E18	F15	646 ⁽³⁾
I/O	P147	P171	D19	E19	649 ⁽³⁾
I/O	P148	P172	C20	E17	652 ⁽³⁾
I/O (D1 ⁽²⁾)	P149	P173	E17	E16	655 ⁽³⁾
I/O	P150	P174	D18	D19	658 ⁽³⁾
I/O	-	-	-	D18	661 ⁽³⁾
I/O	-	-	-	D17	664 ⁽³⁾
I/O	P151	P175	C19	C19	667 ⁽³⁾
I/O	P152	P176	B20	B19	670 ⁽³⁾
I/O (D0 ⁽²⁾ , DIN)	P153	P177	C18	C18	673 ⁽³⁾
I/O, SGCK4 ⁽¹⁾ , GCK6 ⁽²⁾ (DOUT)	P154	P178	B19	B18	676 ⁽³⁾
CCLK	P155	P179	A20	A19	-
VCC	P156	P180	VCC ⁽⁴⁾	VCC ⁽⁴⁾	-



XCS40 and XCS40XL Device Pinouts

XCS40/XL				00000(2 F)	Bndry	
Pad Name	PQ208	PQ240	BG256	CS280 ^(2,5)	Scan	
O, TDO	P157	P181	A19	B17	0	
GND	P158	P182	GND ⁽⁴⁾	GND ⁽⁴⁾	-	
I/O	P159	P183	B18	A18	2	
I/O, PGCK4 ⁽¹⁾ , GCK7 ⁽²⁾	P160	P184	B17	A17	5	
I/O	P161	P185	C17	D16	8	
I/O	P162	P186	D16	C16	11	
I/O (CS1 ⁽²⁾)	P163	P187	A18	B16	14	
I/O	P164	P188	A17	A16	17	
I/O	-	-	-	E15	20	
I/O	-	-	-	C15	23	
I/O	P165	P189	C16	D15	26	
I/O	-	P190	B16	A15	29	
I/O	P166	P191	A16	E14	32	
I/O	P167	P192	C15	C14	35	
I/O	P168	P193	B15	B14	38	
I/O	P169	P194	A15	D14	41	
GND	P170	P196	GND ⁽⁴⁾	GND ⁽⁴⁾	-	
I/O	P171	P197	B14	A14	44	
I/O	P172	P198	A14	C13	47	
I/O	-	P199	C13	B13	50	
I/O	-	P200	B13	A13	53	
VCC	P173	P201	VCC ⁽⁴⁾	VCC ⁽⁴⁾	-	
I/O	-	-	A13	A12	56	
I/O	-	-	D12	C12	59	
I/O	P174	P202	C12	B12	62	
I/O	P175	P203	B12	D12	65	
I/O	P176	P205	A12	A11	68	
I/O	P177	P206	B11	B11	71	
I/O	P178	P207	C11	C11	74	
I/O	P179	P208	A11	D11	77	
I/O	P180	P209	A10	A10	80	
I/O	P181	P210	B10	B10	83	
GND	P182	P211	GND ⁽⁴⁾	GND ⁽⁴⁾	-	
2/8/00	•	•	•	•		

Notes:

- 1. 5V Spartan family only
- 2. 3V Spartan-XL family only
- 3. The "PWRDWN" on the XCS40XL is not part of the Boundary Scan chain. For the XCS40XL, subtract 1 from all Boundary Scan numbers from GCK3 on (343 and higher).
- 4. Pads labeled $\mathrm{GND^{(4)}}$ or $\mathrm{V_{CC}^{(4)}}$ are internally bonded to Ground or $\mathrm{V_{CC}}$ planes within the package.
- CS280 package discontinued by <u>PDN2004-01</u>

Additional XCS40/XL Package Pins

PQ240

	GND Pins								
P22	P37	P83	P98	P143	P158				
P204	P219	-			-				
	Not Connected Pins								
P195	-	-	-	-	-				

2/12/98

BG256

VCC Pins								
C14	D6	D7	D11	D14	D15			
E20	F1	F4	F17	G4	G17			
K4	L17	P4	P17	P19	R2			
R4	R17	U6	U7	U10	U14			
U15	V7	W20	-	-	-			
	GND Pins							
A1	B7	D4	D8	D13	D17			
G20	H4	H17	N3	N4	N17			
U4	U8	U13	U17	W14	-			

6/17/97

CS280

VCC Pins								
A1	A7	B5	B15	C10	C17			
D13	E3	E18	G1	G19	K2			
K17	M4	N16	R3	R18	T7			
U3	U10	U17	V5	V15	W13			
	GND Pins							
E5	E7	E8	E9	E11	E12			
E13	G5	G15	H5	H15	J5			
J15	L5	L15	M5	M15	N5			
N15	R7	R8	R9	R11	R12			
R13	-	-	-	-	-			

5/19/99



Table 20: User I/O Chart for Spartan/XL FPGAs

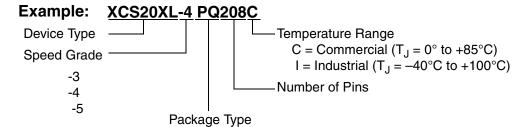
	Max	Package Type								
Device	I/O	PC84 ⁽¹⁾	VQ100 ⁽¹⁾	CS144 ⁽¹⁾	TQ144	PQ208	PQ240	BG256 ⁽¹⁾	CS280 ⁽¹⁾	
XCS05	80	61 ⁽¹⁾	77	-	-	-	-	-	-	
XCS10	112	61 ⁽¹⁾	77	-	112	-	-	-	-	
XCS20	160	-	77	-	113	160	-	-	-	
XCS30	192	-	77 ⁽¹⁾	-	113	169	192	192 ⁽¹⁾	-	
XCS40	224	-	-	-	-	169	192	205	-	
XCS05XL	80	61 ⁽¹⁾	77 ⁽²⁾	-	-	-	-	-	-	
XCS10XL	112	61 ⁽¹⁾	77 ⁽²⁾	112 ⁽¹⁾	112 ⁽²⁾	-	-	-	-	
XCS20XL	160	-	77 ⁽²⁾	113 ⁽¹⁾	113 ⁽²⁾	160 ⁽²⁾	-	-	-	
XCS30XL	192	-	77 ⁽²⁾	-	113 ⁽²⁾	169 ⁽²⁾	192 ⁽²⁾	192 ⁽²⁾	192 ⁽¹⁾	
XCS40XL	224	-	-	-	-	169 ⁽²⁾	192 ⁽²⁾	205 ⁽²⁾	224 ⁽¹⁾	
6/25/08		•	•			•		•		

0/23/00

Notes:

- PC84, CS144, and CS280 packages, and VQ100 and BG256 packages for XCS30 only, discontinued by PDN2004-01
- 2. These Spartan-XL devices are available in Pb-free package options. The Pb-free packages insert a "G" in the package code. Contact Xilinx for availability.

Ordering Information



BG = Ball Grid Array VQ = Very Thin Quad Flat Pack

BGG = Ball Grid Array (Pb-free) VQG = Very Thin Quad Flat Pack (Pb-free)

PC = Plastic Lead Chip Carrier TQ = Thin Quad Flat Pack

PQ = Plastic Quad Flat Pack TQG = Thin Quad Flat Pack (Pb-free)